

From FPGAs to obfuscated eASICs : design and security trade-offs

Abideen, Zain Ul; Perez, Tiago Diadami; Pagliarini, Samuel Nascimento IEEE Asian Hardware-Oriented Security and Trust (AsianHOST) 2021 / p. 1-4 <https://doi.org/10.1109/AsianHOST53231.2021.9699758>

Hardware obfuscation of digital FIR filters

Aksoy, Levent; Hepp, Alexander; Baehr, Johanna; Pagliarini, Samuel Nascimento 2022 25th International Symposium on Design and Diagnostics of Electronic Circuits and Systems (DDECS) : Prague, Czech Republic : April 6-8, 2022 : proceedings 2022 / p. 68-73 <https://doi.org/10.48550/arXiv.2202.10022> <https://doi.org/10.1109/DDECS54261.2022.9770141>

Hardware Trojans for confidence reduction and misclassifications on neural networks

Grailoo, Mahdieh; **Leier, Mairo; Pagliarini, Samuel Nascimento** Proceedings Of The Twenty Third International Symposium On Quality Electronic Design (ISQED 2022) 2022 / art. 180541, p. 230-235 <https://doi.org/10.1109/ISQED54688.2022.9806246>

High-level intellectual property obfuscation via decoy constants

Aksoy, Levent; Nguyen, Quang-Linh; Almeida, Felipe; Raik, Jaan; Flottes, Marie-Lise; Dupuis, Sophie; Pagliarini, Samuel Nascimento 2021 IEEE 27th International Symposium on On-Line Testing and Robust System Design (IOLTS) : Torino, Italy, 28-30 June 2021 2021 / p. 1-7 <https://doi.org/10.1109/IOLTS52814.2021.9486714>

A pragmatic methodology for blind hardware trojan insertion in finalized layouts

Hepp, Alexander; **Perez, Tiago Diadami; Pagliarini, Samuel Nascimento**; Sigl, Georg ICCAD '22: Proceedings of the 41st IEEE/ACM International Conference on Computer-Aided Design 2022 / art. 69, p. 1-9 : ill <https://doi.org/10.1145/3508352.3549452>
[Conference Proceedings at Scopus](#) [Article at Scopus](#) [Article at WOS](#)

A security-aware and LUT-based CAD flow for the physical synthesis of hASICs

Abideen, Zain Ul; Perez, Tiago Diadami; Martins, Mayler; Pagliarini, Samuel Nascimento IEEE transactions on computer-aided design of integrated circuits and systems 2023 / p. 3157-3170 : ill <https://doi.org/10.1109/TCAD.2023.3244879> [Journal metrics at Scopus](#)
[Article at Scopus](#) [Journal metrics at WOS](#) [Article at WOS](#)

A survey on split manufacturing : attacks, defenses, and challenges

Perez, Tiago Diadami; Pagliarini, Samuel Nascimento IEEE Access 2020 / p. 184013-184035
<https://doi.org/10.1109/ACCESS.2020.3029339> [Journal metrics at Scopus](#) [Article at Scopus](#) [Journal metrics at WOS](#) [Article at WOS](#)